

Notice of References Cited	Application/Control No. 10/814,110	Applicant(s)/Patent Under Reexamination CHONO ET AL.	
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*	B	US-2003/0160913 A1	08-2003	Yamashita, Shunichi	349/96
*	C	US-2005/0134778 A1	06-2005	Tsuboi et al.	349/129
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NON-PATENT DOCUMENTS

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